

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/612,615 INOUE ET AL.	
		Examiner	Art Unit Tianjie Chen	2627 Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000285509 A	10-2000	Japan	KINOSHITA et al.	
	O	English Translation only				
	P					
	Q					
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#### NON-PATENT DOCUMENTS

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